## Application/Control No. Applicant(s)/Patent Under Reexamination 10/709,466 CHEN ET AL. **Notice of References Cited** Examiner Art Unit Page 1 of 1 Laura C. Guidotti 1744 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0103491	06-2004	Fujiwara et al.	015/097.1
*	В	US-6,695,917	02-2004	Wright et al.	118/257
	O	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
i	Η	US-			
	_	US-			
	7	US-			
	К	US-			
	L	US-	·		
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name .	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	×	•

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.